

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE										ATTY. DOCKET NO. ARC9-2000-0066-US2										SERIAL NO. 10/765, Not yet assigned 545									
<b>LIST OF PRIOR ART CITED BY APPLICANT</b> (Use several sheets if necessary)																				APPLICANT BAGLIN, John E.E.									
																				FILING DATE Filed Herewith									
<b>U.S. PATENT DOCUMENTS</b>																													
EXAMINER INITIAL				DOCUMENT NUMBER								DATE		NAME								CLASS		SUBCLASS		FILING DATE IF APPROPRIATE			
LAC		A		5 0 7 9 6 6 2								01/07/92		Kawakami et al.															
↑				5 5 5 0 1 0 1								08/27/96		Nagata e al.															
↓				6 0 7 7 6 1 8								06/20/00		Sakamina et al.															
LAC				6 3 1 7 3 0 2								11/13/01		Van Kesteren et al.															
<b>FOREIGN PATENT DOCUMENTS</b>																													
				DOCUMENT NUMBER								DATE		COUNTRY								CLASS		SUBCLASS		TRANSLATION			
																										YES NO			
<b>OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>																													
		B		Yimin Guo et al. in "Low Fringe-Field and Narrow Track MR Heads", IEEE Transactions on Magnetics, Vol. 33, No. 5, Sept. 1997, pp. 2827-9.																									
		C		G.J. Athas et al. "Focused Ion Beam System for Automated MEMS Prototyping and Processing", Proc. SPIE - Int. Soc. Opt. Eng. (USA), Vol. 3223, 1997, pp. 198-207.																									
		D		Charles Partee et al., "Off-Track Response Versus Shield Width at the ABS for MR Heads", IEEE Transactions on Magnetics (USA), Vol. 33, No. 5, Pt. 1, Sept. 1997, pp. 2887-9.																									
		E		W.M. Kaminsky et al., "Patterning Ferromagnetism in $Ni_{80}Fe_{20}$ Films via 30 keV $Ga^+$ on Irradiation", Applied Physics Letters, March 30 2000.																									
EXAMINER L. AC															DATE CONSIDERED 7/8/4														
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.																													